

Design and Analysis of Machine Learning Experiments

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COMPLEXITY OF
MACHINE LEARNING

STATISTICAL
ANALYSIS

PARALLEL
PROCESSING

MULTI
MODALITY

KERNEL
MACHINES

SUPER
FEATURE
DETECTORS

Introduction

- Questions:
 - Is the error rate of my classifier less than 2%?
 - Is k -NN more accurate than MLP?
 - Does having PCA before improve accuracy?
 - Which kernel leads to highest accuracy with SVM?

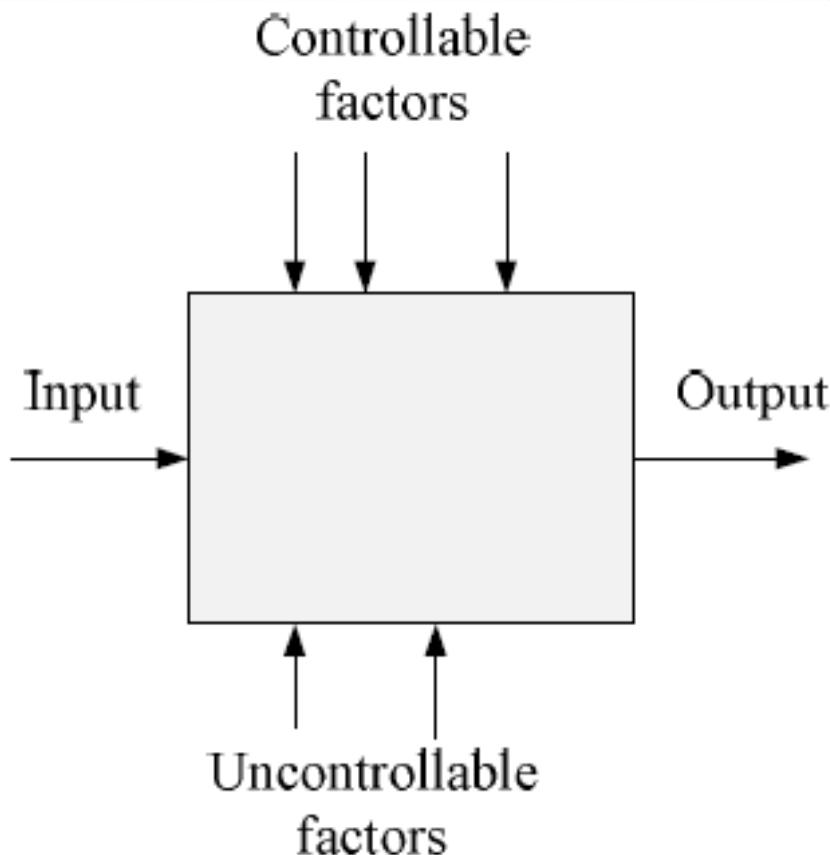
Material

- Training/validation/test sets
- Resampling methods
- Comparing multiple algorithms on a single data set
- Comparison on multiple data sets

Algorithm Preference

- Criteria (Application-dependent):
 - Misclassification error, or risk (loss functions)
 - Training time/space complexity
 - Testing time/space complexity
 - Interpretability
 - Easy programmability
- Cost-sensitive learning

Experiment Design: Factors and Response



Controllable factors:

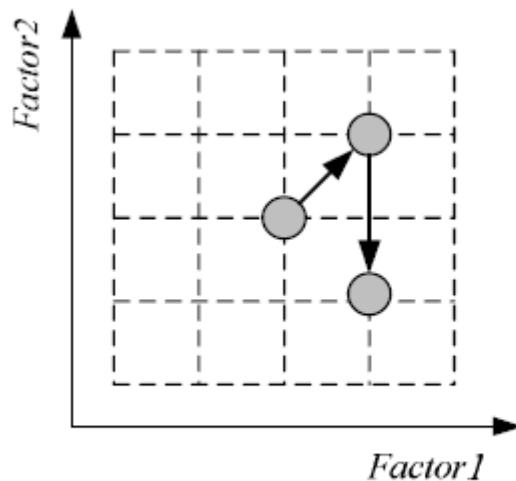
- Learning algorithm
- Hyperparameters
- Input representation

Uncontrollable factors:

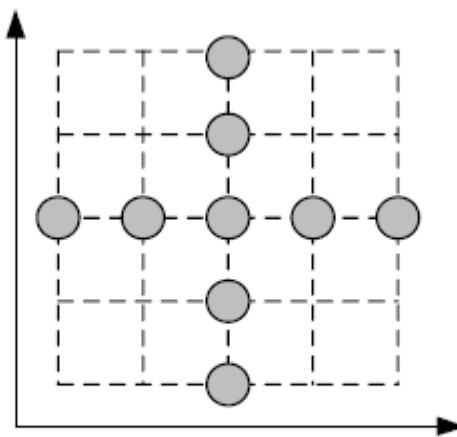
- Noise in data
- Randomness in splitting
- Randomness in optimization

Arrive to conclusions not affected by chance, i.e., **statistically significant**.

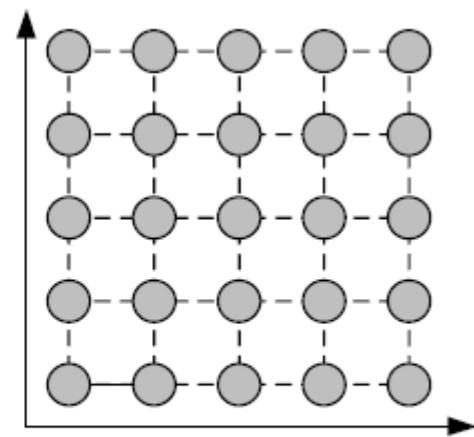
Strategies of Experimentation



(a) Best guess



(b) One factor at a time



(c) Factorial design

Response surface design

Basic Principles of Experimental Design

1. **Randomization:** Independence of results, unaffected by order
2. **Replication:** Average over chance and uncontrollable factors (k-fold cv)
3. **Blocking:** Reduce or eliminate the variability due to nuisance factors: Paired tests

Guidelines for ML experiments

A. Aim of the study:

Compare hyperparameters or two or more algorithms

Single/multiple data sets

B. Selection of the response variable

Accuracy/precision-recall/loss function

Cost-conscious framework

C. Choice of factors and levels

What are the factors to be played with?

What are the factor levels?

Guidelines (cont'd)

D. Choice of experimental design

Factorial design (grid search)

How many replicates?

E. Performing the experiment

Unbiased in experimentation, a separate tester

Good code and documentation

F. Statistical Analysis of the Data

Hypothesis testing

Visualization of results: Histograms, plots

G. Conclusions and Recommendations

Draw objective conclusions

Splitting Data

- The need for training, validation, and test sets
 - Training set: Optimize parameters
 - Validation set: Optimize hyperparameters
 - Test set: Measure generalization performance
- Use data once.

Resampling and K-Fold Cross-Validation

- The need for multiple training/validation sets
 $\{\mathcal{X}_i, \mathcal{V}_i\}_i$: Training/validation sets of fold i
- Stratification
- K -fold cross-validation: Divide X into k , $\mathcal{X}_i, i=1,\dots,K$

$$\mathcal{V}_1 = \mathcal{X}_1 \quad \mathcal{T}_1 = \mathcal{X}_2 \cup \mathcal{X}_3 \cup \dots \cup \mathcal{X}_K$$

$$\mathcal{V}_2 = \mathcal{X}_2 \quad \mathcal{T}_2 = \mathcal{X}_1 \cup \mathcal{X}_3 \cup \dots \cup \mathcal{X}_K$$

⋮

$$\mathcal{V}_K = \mathcal{X}_K \quad \mathcal{T}_K = \mathcal{X}_1 \cup \mathcal{X}_2 \cup \dots \cup \mathcal{X}_{K-1}$$

- T_i share $K-2$ parts

5x2 Cross-Validation

(Dietterich, 1998, Neural Computation)

$$\mathcal{T}_1 = \mathcal{X}_1^{(1)} \quad \mathcal{V}_1 = \mathcal{X}_1^{(2)}$$

$$\mathcal{T}_2 = \mathcal{X}_1^{(2)} \quad \mathcal{V}_2 = \mathcal{X}_1^{(1)}$$

$$\mathcal{T}_3 = \mathcal{X}_2^{(1)} \quad \mathcal{V}_3 = \mathcal{X}_2^{(2)}$$

$$\mathcal{T}_4 = \mathcal{X}_2^{(2)} \quad \mathcal{V}_4 = \mathcal{X}_2^{(1)}$$

⋮

$$\mathcal{T}_9 = \mathcal{X}_5^{(1)} \quad \mathcal{V}_9 = \mathcal{X}_5^{(2)}$$

$$\mathcal{T}_{10} = \mathcal{X}_5^{(2)} \quad \mathcal{V}_{10} = \mathcal{X}_5^{(1)}$$

Bootstrapping

- Draw instances from a dataset *with replacement*
- Prob that we do not pick an instance after N draws

$$\left(1 - \frac{1}{N}\right)^N \approx e^{-1} = 0.368$$

that is, only 36.8% is new!

Making Decisions and Error

- Classifier predicts + if $P(+|x) > \theta$ and predicts - otherwise

Prediction		
Truth	+	-
+	0	λ
-	1	0

$$R(+|x) = \lambda_{11}P(+|x) + \lambda_{12}P(-|x) = P(-|x)$$

$$R(-|x) = \lambda P(+|x)$$

predict x as positive if

$$R(+|x) < R(-|x), \text{ or if } P(-|x) < \lambda P(+|x)$$

$$P(+|x) > \frac{1}{1 + \lambda}$$

Measures of Performance

2×2 CONFUSION MATRIX

		Prediction		
		+	-	Total
Truth	+	tp	fn	p
-	fp	tn		n
Total		p'	n'	N

$$\text{error rate} = \frac{fp + fn}{N}$$

$$\text{tp-rate} = \frac{tp}{p}$$

$$\text{recall} = \frac{tp}{p}$$

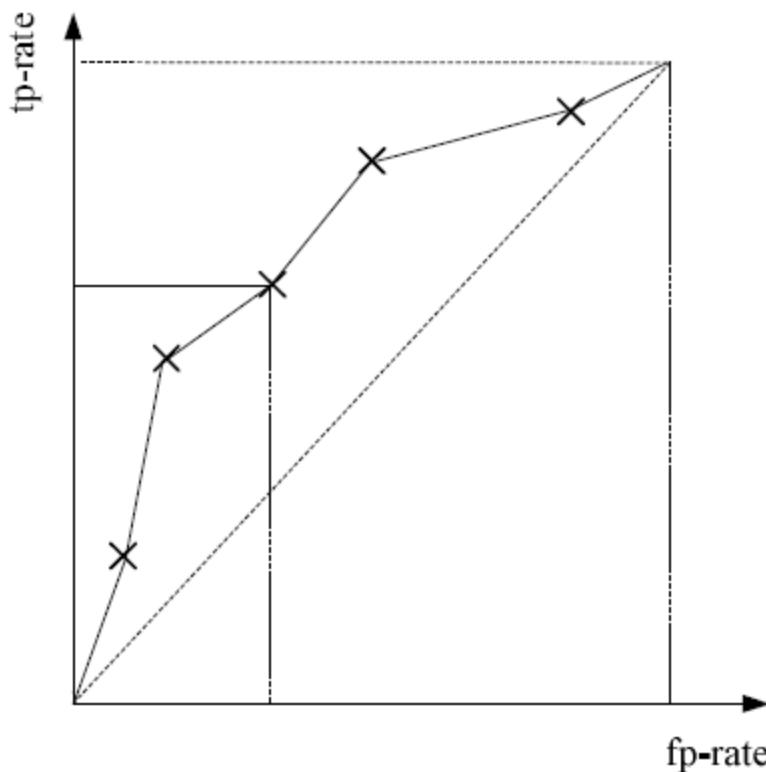
$$\text{sensitivity} = \frac{tp}{p}$$

$$\text{accuracy} = \frac{tp + tn}{N}$$

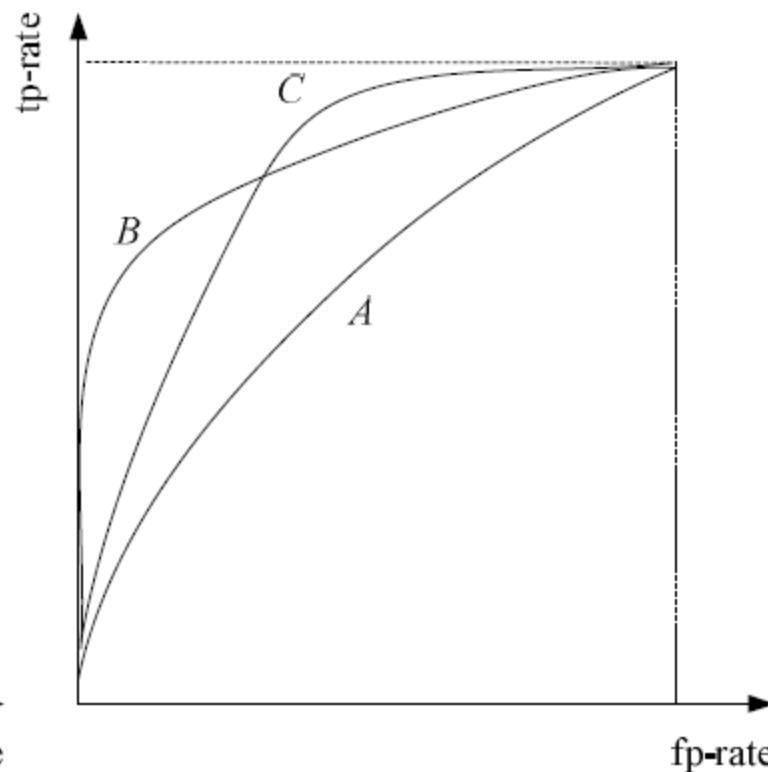
$$\text{fp-rate} = \frac{fp}{n}$$

$$\text{precision} = \frac{tp}{p'}$$

$$\text{specificity} = \frac{tn}{n}$$

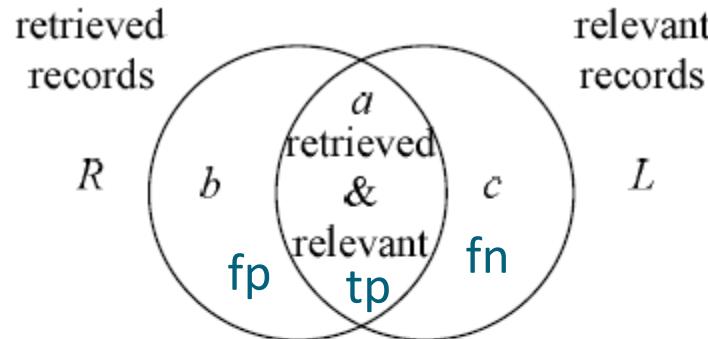


(a) Example ROC curve



(b) Different ROC curves for different classifiers

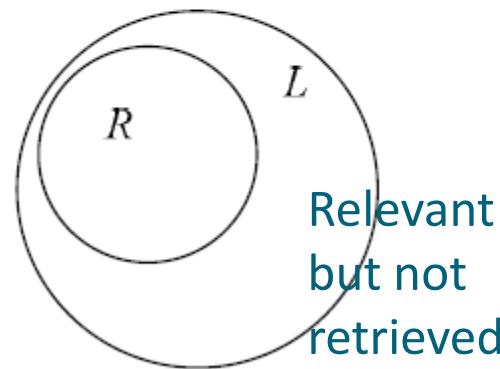
Precision and Recall



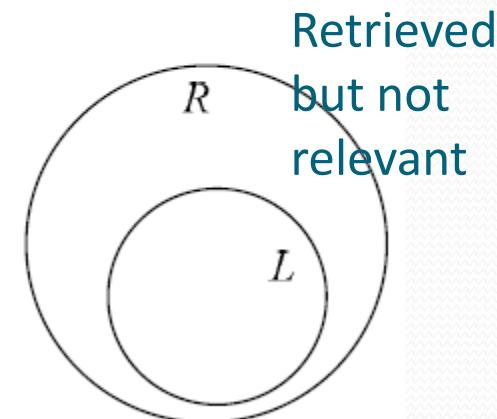
$$\text{Precision: } \frac{a}{a + b}$$

$$\text{Recall: } \frac{a}{a + c}$$

(a) Precision and recall

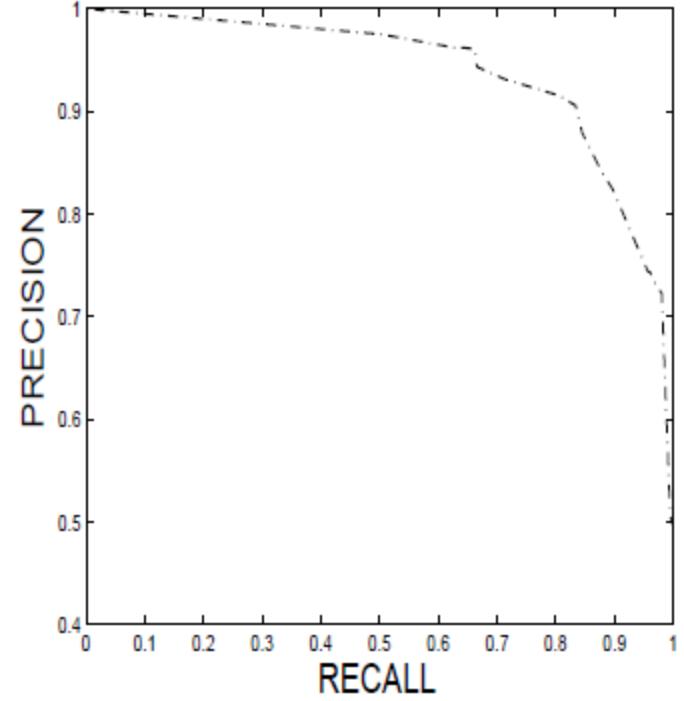
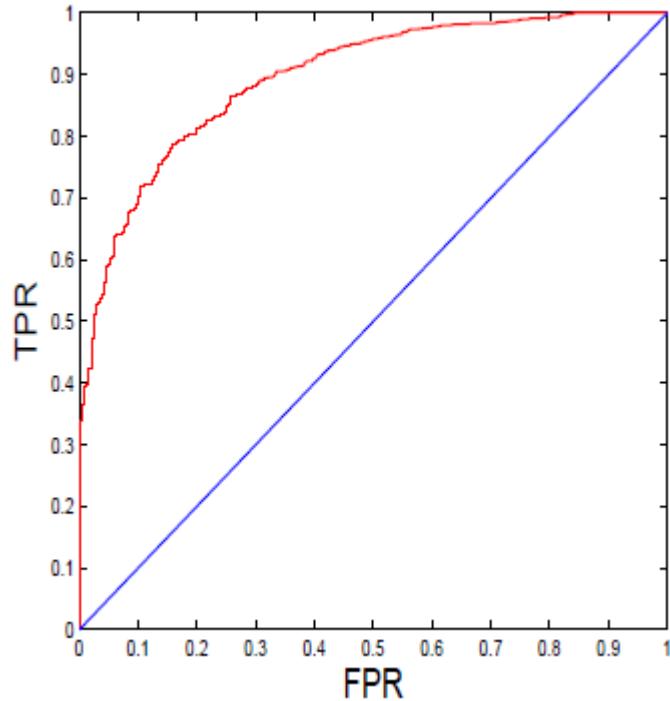


(b) Precision = 1



(c) Recall = 1

ROC – Precision/Recall Curves



		(a)	
		Prediction	
Truth	+	-	Sum
+	80	20	100
-	20	180	200
Sum	100	200	300

$$\text{tp-rate} = 80/100 = 0.8$$

$$\text{fp-rate} = 20/200 = 0.1$$

$$\text{precision} = 80/100 = 0.8$$

$$\text{recall} = 80/100 = 0.8$$

		(b)	
		Prediction	
Truth	+	-	Sum
+	64	16	80
-	22	198	220
Sum	86	214	300

$$\text{tp-rate} = 64/80 = 0.8$$

$$\text{fp-rate} = 22/220 = 0.1$$

$$\text{precision} = 64/86 = 0.74$$

$$\text{recall} = 64/80 = 0.8$$

		(c)	
		Prediction	
Truth	+	-	Sum
+	80	20	100
-	20	580	600
Sum	100	600	700

$$\text{tp-rate} = 80/100 = 0.8$$

$$\text{fp-rate} = 20/600 = 0.03$$

$$\text{precision} = 80/100 = 0.8$$

$$\text{recall} = 80/100 = 0.8$$

Statistics Review: Sampling

- $X = \{x^t\}_t$ where $x^t \sim N(\mu, \sigma^2)$
- $m \sim N(\mu, \sigma^2/N)$ $m = \frac{\sum_t x^t}{N}$
- Implication for model combination

$$E[y] = E\left[\sum_j \frac{1}{L} d_j\right] = \frac{1}{L} L E[d_j] = E[d_j]$$

$$\text{Var}(y) = \text{Var}\left(\sum_j \frac{1}{L} d_j\right) = \frac{1}{L^2} \text{Var}\left(\sum_j d_j\right)$$

$$\text{Var}(y) = \frac{1}{L^2} \text{Var}\left(\sum_j d_j\right) = \frac{1}{L^2} \left[\sum_j \text{Var}(d_j) + 2 \sum_j \sum_{i < j} \text{Cov}(d_j, d_i) \right]$$

Ulaş et al (2009), Info Sci

Interval Estimation

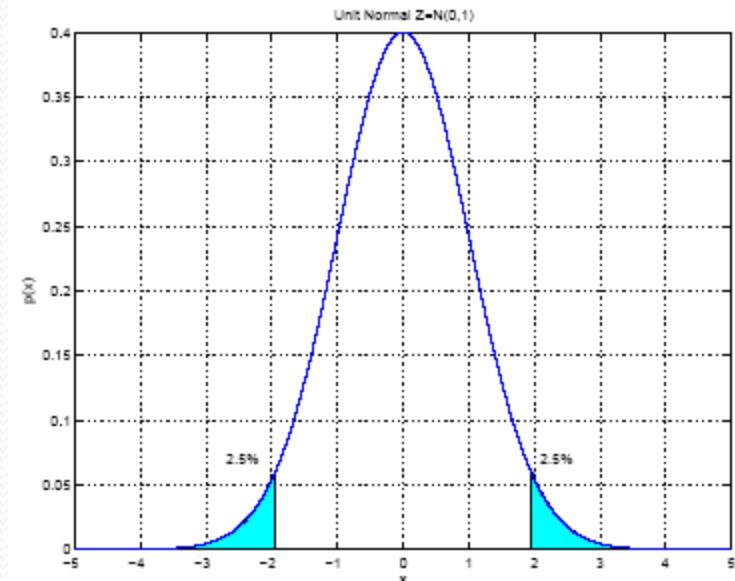
$$\sqrt{N} \frac{(m - \mu)}{\sigma} \sim Z$$

$$P\left\{-1.96 < \sqrt{N} \frac{(m - \mu)}{\sigma} < 1.96\right\} = 0.95$$

$$P\left\{m - 1.96 \frac{\sigma}{\sqrt{N}} < \mu < m + 1.96 \frac{\sigma}{\sqrt{N}}\right\} = 0.95$$

$$P\left\{m - z_{\alpha/2} \frac{\sigma}{\sqrt{N}} < \mu < m + z_{\alpha/2} \frac{\sigma}{\sqrt{N}}\right\} = 1 - \alpha$$

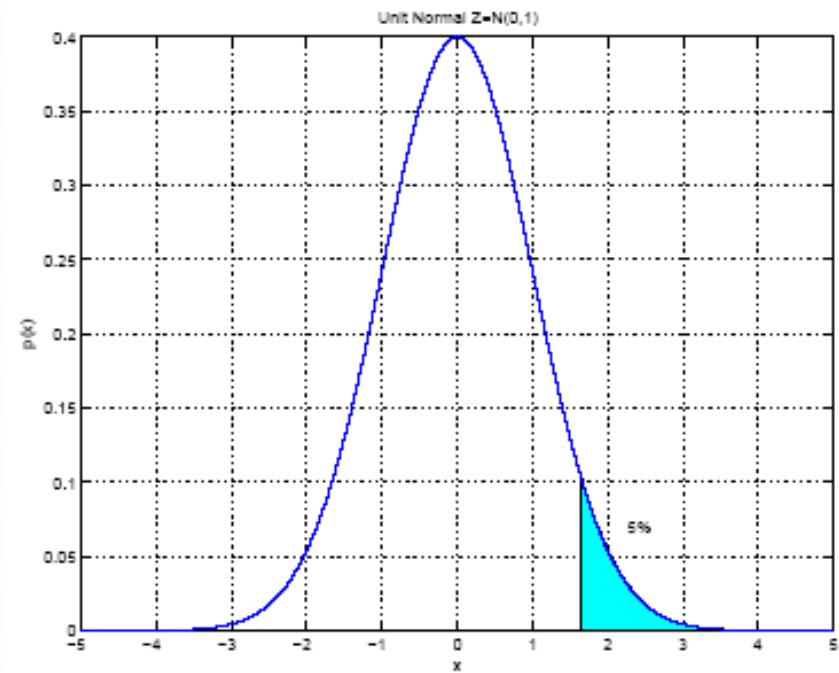
100(1 - α) percent confidence interval



$$P\left\{\sqrt{N} \frac{(m-\mu)}{\sigma} < 1.64\right\} = 0.95$$

$$P\left\{m - 1.64 \frac{\sigma}{\sqrt{N}} < \mu\right\} = 0.95$$

$$P\left\{m - z_{\alpha} \frac{\sigma}{\sqrt{N}} < \mu\right\} = 1 - \alpha$$



When σ^2 is not known:

$$s^2 = \sum_t (x^t - m)^2 / (N - 1)$$

$$\frac{\sqrt{N}(m - \mu)}{s} \sim t_{N-1}$$

$$P\left\{ m - t_{\alpha/2, N-1} \frac{s}{\sqrt{N}} < \mu < m + t_{\alpha/2, N-1} \frac{s}{\sqrt{N}} \right\} = 1 - \alpha$$

Hypothesis Testing

- Reject a null hypothesis if not supported by the sample with enough confidence

	Decision	
Truth	Fail to reject	Reject
True	Correct	Type I error
False	Type II error	Correct (power)

- $H_0: \mu = \mu_0$ vs. $H_1: \mu \neq \mu_0$

Accept H_0 with level of significance α if μ_0 is in the $100(1 - \alpha)$ confidence interval

$$\frac{\sqrt{N}(m - \mu_0)}{\sigma} \in (-z_{\alpha/2}, z_{\alpha/2})$$

Two-sided test

- Type II error

$$\beta(\mu) = P_\mu \left\{ -z_{\alpha/2} \leq \frac{m - \mu_0}{\sigma / \sqrt{N}} \leq z_{\alpha/2} \right\}$$

- How large a sample?

- One-sided test: $H_0: \mu \leq \mu_0$ vs. $H_1: \mu > \mu_0$

Accept if

$$\frac{\sqrt{N}(m - \mu_0)}{\sigma} \in (-\infty, z_\alpha)$$

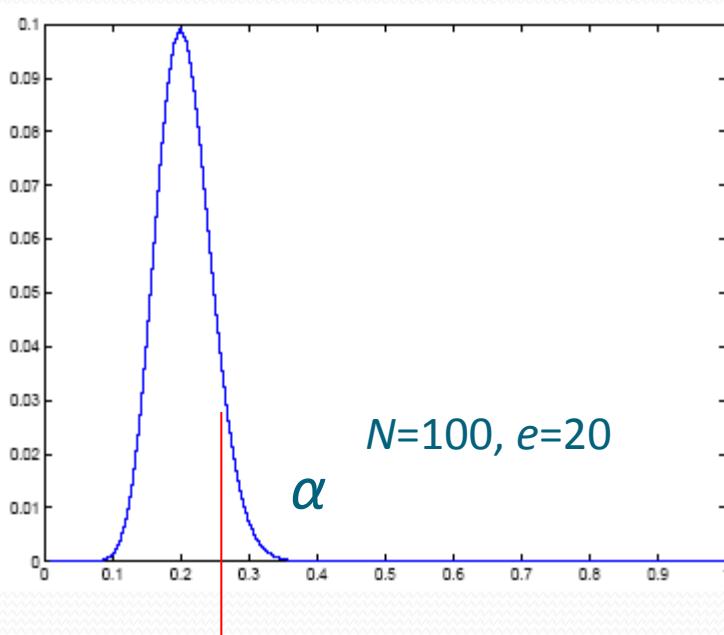
- Variance unknown: Use t , instead of z

Accept $H_0: \mu = \mu_0$ if

$$\frac{\sqrt{N}(m - \mu_0)}{S} \in (-t_{\alpha/2, N-1}, t_{\alpha/2, N-1})$$

Assessing Error: $H_0: p \leq p_0$ vs. $H_1: p > p_0$

- Single training/validation set: Binomial Test
If error prob is p_0 , prob that there are e errors or more

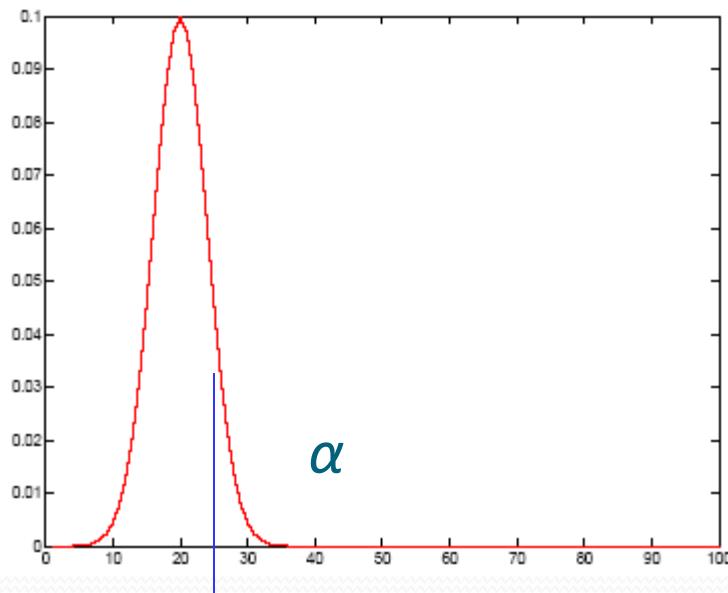


$$P\{X \geq e\} = \sum_{j=e}^N \binom{N}{j} p_0^j (1-p_0)^{N-j}$$

Reject if this prob is less than α

Normal Approximation to the Binomial

- $H_0: \mu < \mu_o$ vs. $H_1: \mu > \mu_o$
- Number of errors X is approx Normal (CLT) with mean Np_0 and var $Np_0(1-p_0)$



$$z = \frac{e - Np_0}{\sqrt{Np_0(1-p_0)}} \sim Z$$

Reject if $z > z_\alpha$

t Test

- Multiple training/validation sets
- $x_i^t = 1$ if instance t misclassified on fold i
- Error rate of fold i : $p_i = \frac{\sum_{t=1}^N x_i^t}{N}$
- With m and s^2 average and var of p_i , we reject p_0 or less error if

$$\frac{\sqrt{K}(m - p_0)}{S} \sim t_{K-1}$$

is greater than $t_{\alpha, K-1}$

Comparing Classifiers:

$H_0: \mu_1 = \mu_2$ vs. $H_1: \mu_1 \neq \mu_2$

- Single training/validation set: McNemar's Test

e_{00} : Number of examples misclassified by both	e_{01} : Number of examples misclassified by 1 but not 2
e_{10} : Number of examples misclassified by 2 but not 1	e_{11} : Number of examples correctly classified by both

- Under H_0 , we expect $e_{01} = e_{10} = (e_{01} + e_{10})/2$

$$\frac{(|e_{01} - e_{10}| - 1)^2}{e_{01} + e_{10}} \sim \chi^2_1$$

Accept if $< \chi^2_{\alpha,1}$

K-Fold CV Paired t Test

- Use K -fold cv to get K training/validation folds
- p_i^1, p_i^2 : Errors of classifiers 1 and 2 on fold i
- $p_i = p_i^1 - p_i^2$: Paired difference on fold i
- The null hypothesis is whether p_i has mean 0

$$H_0 : \mu = 0 \text{ vs. } H_1 : \mu \neq 0$$

$$m = \frac{\sum_{i=1}^K p_i}{K} \quad s^2 = \frac{\sum_{i=1}^K (p_i - m)^2}{K-1}$$

$$\frac{\sqrt{K}(m-0)}{s} = \frac{\sqrt{K} \cdot m}{s} \sim t_{K-1} \text{ Accept if in } (-t_{\alpha/2, K-1}, t_{\alpha/2, K-1})$$

~~5x2 cv Paired t Test~~

(Dietterich, 1998, Neural Computation)

- Use 5×2 cv to get 2 folds of 5 tra/val replications
- $p_i^{(j)}$: difference btw errors of 1 and 2 on fold $j=1, 2$ of replication $i=1, \dots, 5$

$$\bar{p}_i = (p_i^{(1)} + p_i^{(2)})/2 \quad s_i^2 = (p_i^{(1)} - \bar{p}_i)^2 + (p_i^{(2)} - \bar{p}_i)^2$$

$$\frac{p_1^{(1)}}{\sqrt{\sum_{i=1}^5 s_i^2 / 5}} \sim t_5$$

Two-sided test: Accept $H_0: \mu_0 = \mu_1$ if in $(-t_{\alpha/2,5}, t_{\alpha/2,5})$

One-sided test: Accept $H_0: \mu_0 \leq \mu_1$ if $< t_{\alpha,5}$

5×2 cv Paired F Test

(Alpaydın, 1999, Neural Computation)

$$\frac{\sum_{i=1}^5 \sum_{j=1}^2 (p_i^{(j)})^2}{2 \sum_{i=1}^5 s_i^2} \sim F_{10,5}$$

Two-sided test: Reject $H_0: \mu_0 = \mu_1$ if $> F_{\alpha, 10, 5}$

Comparing $L > 2$ Algorithms: Analysis of Variance (Anova)

$$H_0 : \mu_1 = \mu_2 = \dots = \mu_L$$

- Errors of L algorithms on K folds

$$x_{ij} \sim \mathcal{N}(\mu_j, \sigma^2), j=1, \dots, L, i=1, \dots, K$$

- We construct two estimators to σ^2 .

One is valid if H_0 is true, the other is always valid.

We reject H_0 if the two estimators disagree.

If H_0 is true:

$$m_j = \sum_{i=1}^K \frac{X_{ij}}{K} \sim \mathcal{N}(\mu, \sigma^2 / K)$$

$$m = \frac{\sum_{j=1}^L m_j}{L} \quad S^2 = \frac{\sum_j (m_j - m)^2}{L-1}$$

Thus an estimator of σ^2 is $K \cdot S^2$, namely,

$$\hat{\sigma}^2 = K \sum_{j=1}^L \frac{(m_j - m)^2}{L-1}$$

$$\sum_j \frac{(m_j - m)^2}{\sigma^2 / K} \sim \chi_{L-1}^2 \quad SSb \equiv K \sum_j (m_j - m)^2$$

So when H_0 is true, we have

$$\frac{SSb}{\sigma^2} \sim \chi_{L-1}^2$$

Regardless of H_0 our second estimator to σ^2 is the average of group variances S_j^2 :

$$S_j^2 = \frac{\sum_{i=1}^K (x_{ij} - m_j)^2}{K-1} \quad \hat{\sigma}^2 = \sum_{j=1}^L S_j^2 = \sum_j \sum_i \frac{(x_{ij} - m_j)^2}{L(K-1)}$$

$$SSW \equiv \sum_j \sum_i (x_{ij} - m_j)^2$$

$$(K-1) \frac{S_j^2}{\sigma^2} \sim \chi_{K-1}^2 \quad \frac{SSW}{\sigma^2} \sim \chi_{L(K-1)}^2$$

$$\left(\frac{SSB / \sigma^2}{L-1} \right) / \left(\frac{SSW / \sigma^2}{L(K-1)} \right) = \frac{SSB / (L-1)}{SSW / (L(K-1))} \sim F_{L-1, L(K-1)}$$

Reject $H_0: \mu_1 = \mu_2 = \dots = \mu_L$ if $> F_{\alpha, L-1, L(K-1)}$

ANOVA table

Source of variation	Sum of squares	Degrees of freedom	Mean square	F_0
Between groups	$SS_b \equiv K \sum_j (m_j - m)^2$	$L - 1$	$MS_b = \frac{SS_b}{L-1}$	$\frac{MS_b}{MS_w}$
Within groups	$SS_w \equiv \sum_j \sum_i (X_{ij} - m_j)^2$	$L(K - 1)$	$MS_w = \frac{SS_w}{L(K-1)}$	
Total	$SS_T \equiv \sum_j \sum_i (X_{ij} - m)^2$	$L \cdot K - 1$		

If ANOVA rejects, we do pairwise posthoc tests

$$H_0 : \mu_i = \mu_j \text{ vs } H_1 : \mu_i \neq \mu_j$$

$$t = \frac{m_i - m_j}{\sqrt{2}\sigma_w} \sim t_{L(K-1)}$$

More on Comparing Multiple Populations

- Range tests: Newman-Keuls test

5 2 4 3 1

- Contrasts: Check if significant difference between 1,2 and 3,4,5.

$$H_0: (\mu_1 + \mu_2)/2 = (\mu_3 + \mu_4 + \mu_5)/3 \text{ vs.}$$

$$H_1: (\mu_1 + \mu_2)/2 \neq (\mu_3 + \mu_4 + \mu_5)/3$$

MultiTest: Comparison of $L > 2$ algorithms (Yıldız and Alpaydın, 2006, IEEE T Pami)

- Generate a full ordering using pairwise tests and prior ordering
- Order algorithms in decreasing order of prior preference (e.g., based on complexity)
- Form a directed graph using pairwise one-sided tests with i preferred over j

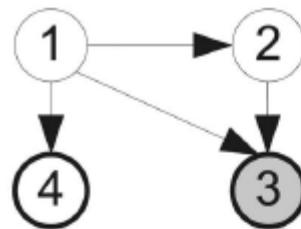
$$H_0 : \mu_i \leq \mu_j$$

- If the test rejects, we add an edge from i to j , to show that j is preferred over i .

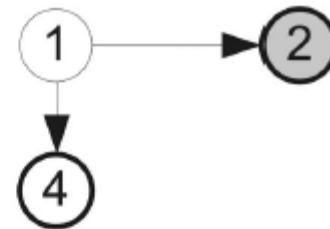
MultiTest: Pseudo-code

```
1 Best MultiTest( $1, \dots, K; T; \alpha$ )
2    $E \leftarrow \emptyset$  /* Edges of the graph */
3   for  $i = 1$  to  $K$ 
4     for  $j = i + 1$  to  $K$ 
5       Test  $H_0: \mu_i \leq \mu_j$  using  $T$ 
6       if  $H_0$  rejected  $E \leftarrow E \cup e[i, j]$  ( $\alpha/(K(K - 1)/2)$ ) /* Bonferroni */
7        $S_k = \{x : \forall e[j, k] \in E, j \neq x\}$ ; /* Find the nodes with no outgoing edges */
8        $l = \forall j \in S_k, l \leq j$ ; /* Select node  $l$  with the lowest index */
9   return  $l$ ;
```

MultiTest



(a)



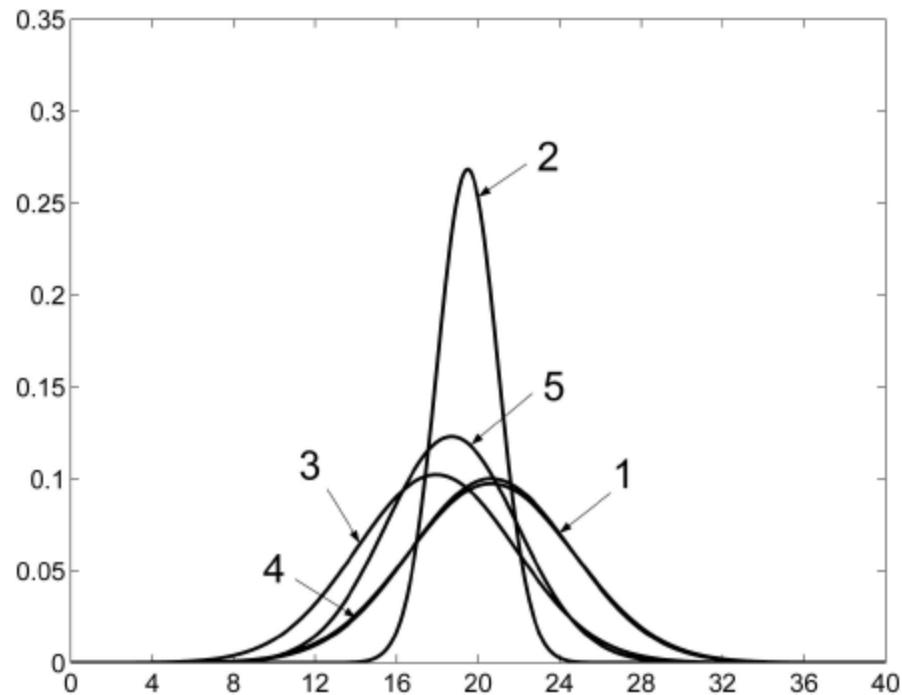
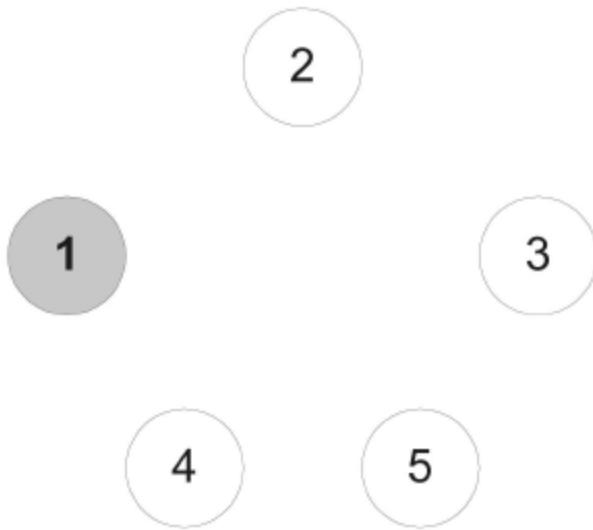
(b)

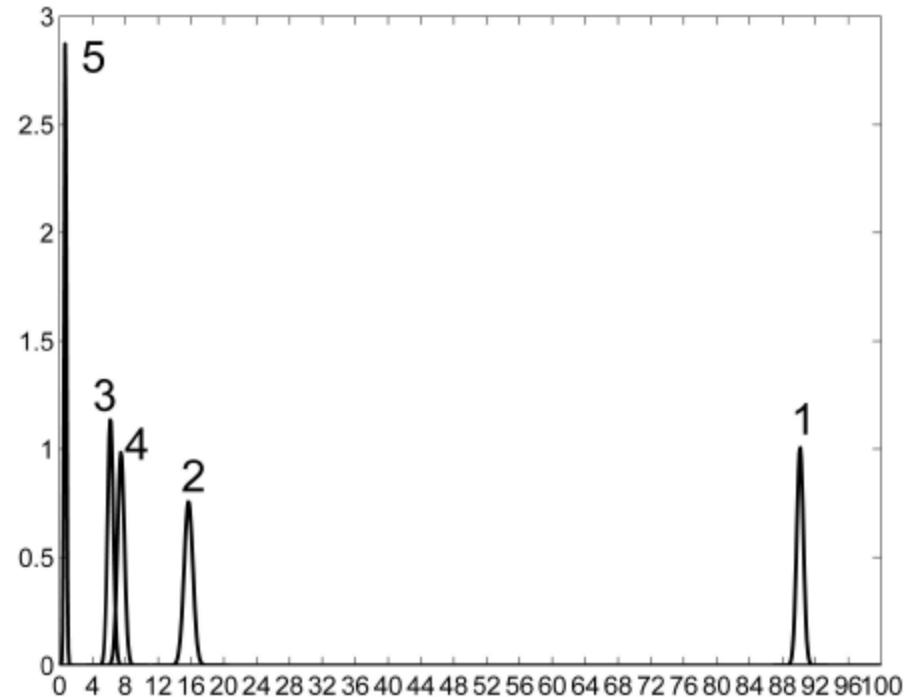
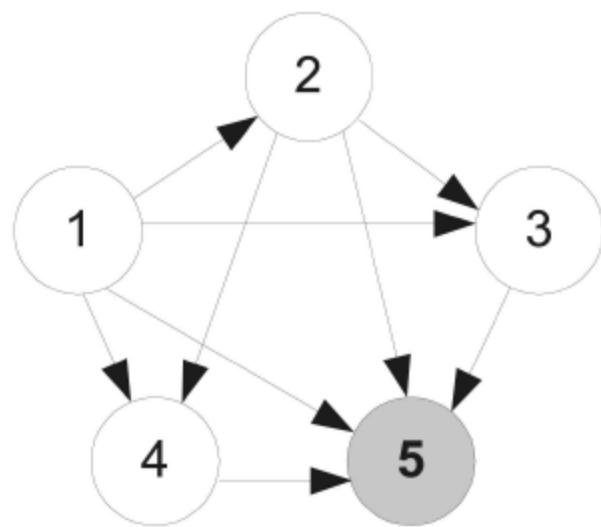


(c)



(d)





$$5 < 3 < 4 < 2 < 1$$

Nonparametric Tests

- If the normality assumption does not hold, it does not make sense to take or compare averages
- Comparison of training times, memory needs, and so on
- Comparison over multiple data sets
- We can use order and rank information

Sign test

- Comparing two algorithms:

Sign test: Count how many times A beats B over N datasets, and check if this could have been by chance if A and B did have the same error rate

$$P\{X \leq e\} = \sum_{x=0}^e \binom{N}{x} \left(\frac{1}{2}\right)^x \left(\frac{1}{2}\right)^{N-x}$$

- Wilcoxon signed rank test

Kruskal-Wallis Test

- Comparing multiple algorithms

Kruskal-Wallis test: Calculate the average rank of all algorithms on M datasets, and check if these could have been by chance if they all had equal error

$$H_0 : \mu_1 = \mu_2 = \dots = \mu_L$$

$$H = \frac{12}{(M+1)L} \sum_{i=1}^L \left(\bar{R}_{i\bullet} - \frac{M+1}{2} \right)$$

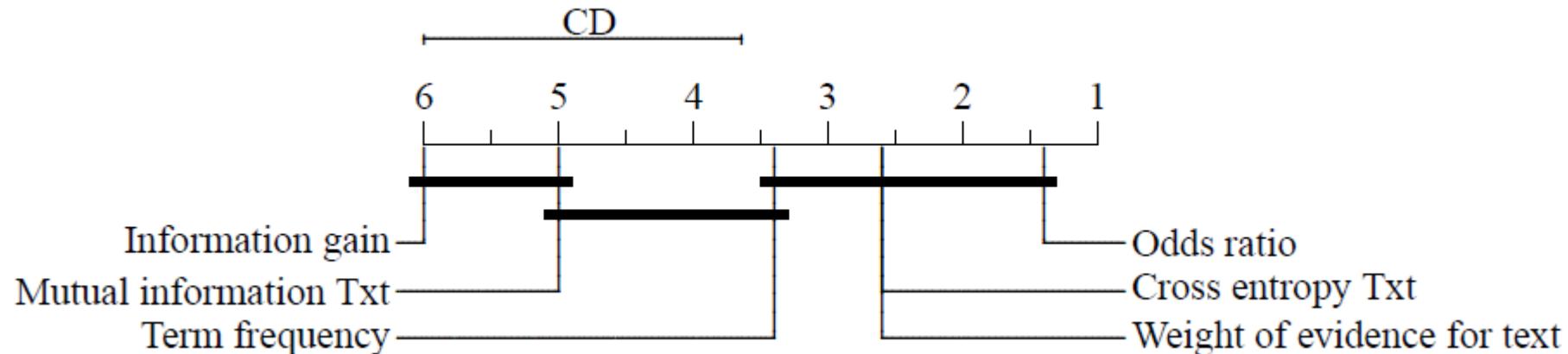
If KW rejects, we do pairwise posthoc tests

Tukey's test: $|\bar{R}_{i\bullet} - \bar{R}_{j\bullet}| > q_\alpha(L, L(K-1)) \sigma_w$

Critical Difference diagrams

(Demsar, 2006, JMLR)

- Friedman's test followed by Nemenyi's posthoc test for pairwise comparisons



Conclusions

- “See first, think later, then test. But always see first. Otherwise you will only see what you were expecting.”
 - Douglas Adams “So long and thanks for all the fish”
- Testing is not a separate step done after all runs are completed, but the whole experimental process should be designed beforehand.

References

- Alpaydın, E. 2010. *Introduction to Machine Learning*, 2nd edition, The MIT Press. This presentation is based on Chapter 19 of this book.
- Demsar, J. 2006. ``Statistical Comparison of Classifiers over Multiple Data Sets.'' *Journal of Machine Learning Research* 7: 1--30.
- Dietterich, T. G. 1998. ``Approximate Statistical Tests for Comparing Supervised Classification Learning Algorithms.'' *Neural Computation* 10: 1895--1923.
- Fawcett, T. 2006. ``An Introduction to ROC Analysis.'' *Pattern Recognition Letters* 27: 861--874.
- Montgomery, D. C. 2005. *Design and Analysis of Experiments*. 6th ed., New York: Wiley.
- Yıldız, O. T., and E. Alpaydın. 2006. ``Ordering and Finding the Best of K>2 Supervised Learning Algorithms.'' *IEEE Transactions on Pattern Analysis and Machine Intelligence* 28: 392--402.